

March 2008

# **FDMC8296**

# N-Channel Power Trench<sup>®</sup> MOSFET 30V, 18A, 8.0m $\Omega$

### **Features**

- Max  $r_{DS(on)} = 8.0 \text{m}\Omega$  at  $V_{GS} = 10 \text{V}$ ,  $I_D = 12 \text{A}$
- Max  $r_{DS(on)} = 13.0 \text{m}\Omega$  at  $V_{GS} = 4.5 \text{V}$ ,  $I_D = 10 \text{A}$
- High performance trench technology for extremely low r<sub>DS(on)</sub>
- Termination is Lead-free and RoHS Compliant

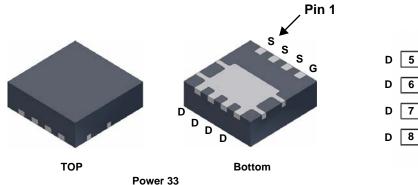


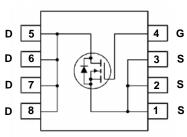
### **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

### **Application**

- High side in DC DC Buck Converters
- Notebook battery power management
- Load switch in Notebook





**MOSFET Maximum Ratings**  $T_A = 25$ °C unless otherwise noted

Symbol	Parameter			Ratings	Units
$V_{DS}$	Drain to Source Voltage			30	V
$V_{GS}$	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25°C		18	
	-Continuous (Silicon limited)	T <sub>C</sub> = 25°C		44	^
ID	-Continuous	T <sub>A</sub> = 25°C	(Note 1a)	12	A
	-Pulsed			52	
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	60	mJ
Б	Power Dissipation	T <sub>C</sub> = 25°C		27	W
$P_{D}$	Power Dissipation	T <sub>A</sub> = 25°C	(Note 1a)	2.3	VV
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	4.6	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	C/VV

### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC8296	FDMC8296	Power 33	13"	12mm	3000 units

## **Electrical Characteristics** T<sub>J</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, referenced to 25°C		17		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24V,$ $V_{GS} = 0V,$ $T_{J} = 125^{\circ}C$			1 250	μА
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

#### On Characteristics

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu A$	1.0	1.9	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, referenced to 25°C		-6		mV/°C
		$V_{GS} = 10V, I_D = 12A$		6.5	8.0	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 4.5V, I_D = 10A$		9.5	13.0	mΩ
		$V_{GS} = 10V, I_D = 12A, T_J = 125$ °C		9.0	12.8	
9 <sub>FS</sub>	Forward Transconductance	$V_{DD} = 5V, I_{D} = 12A$		44		S

### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 45V V 0V	1038	1385	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 15V, V_{GS} = 0V,$ $f = 1MHz$	513	685	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 11/11/12	87	135	pF
$R_g$	Gate Resistance	f = 1MHz	0.9		Ω

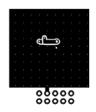
### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time	.,	9	18	ns
t <sub>r</sub>	Rise Time	$V_{DD} = 15V, I_{D} = 12A,$ $V_{GS} = 10V, R_{GEN} = 6\Omega$	3	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = 10V, K <sub>GEN</sub> = 652	19	35	ns
t <sub>f</sub>	Fall Time		2	10	ns
0	Total Gate Charge	V <sub>GS</sub> = 0V to 10V	16	23	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0V \text{ to } 4.5V$ $V_{DD} = 15V$ ,	7.6	10.6	nC
Q <sub>gs</sub>	Total Gate Charge	I <sub>D</sub> = 12A	3		nC
$Q_{gd}$	Gate to Drain "Miller" Charge		2.5		nC

### **Drain-Source Diode Characteristics**

V <sub>SD</sub> Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 12A$ (Note 2)	0.	.82	1.3	W	
V <sub>SD</sub>	Source to Drain blode Forward voltage	$V_{GS} = 0V, I_S = 1.9A$ (Note 2)	0	.73	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	$I_{\rm F} = 12$ A, di/dt = 100A/us	2	25	45	ns
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 12A, di/dt = 100A/μs		9	18	nC

<sup>1.</sup> R<sub>0,1/2</sub> is determined with the device mounted on a 1in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0,1/2</sub> is guaranteed by design while R<sub>0,1/2</sub> is determined by the user's board design.



a. 53°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 125°C/W when mounted on a minimum pad of 2 oz copper

<sup>2.</sup> Pulse Test: Pulse Width <  $300\mu s,$  Duty cycle < 2.0%.

<sup>3.</sup> Starting  $T_J$  = 25°C; N-ch: L = 1 mH,  $I_{AS}$  = 11A,  $V_{DD}$  = 27V,  $V_{GS}$  = 10V.

# **Typical Characteristics** $T_J = 25$ °C unless otherwise noted

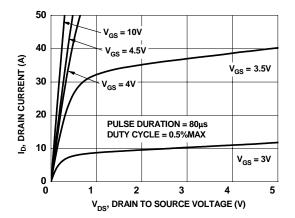


Figure 1. On-Region Characteristics

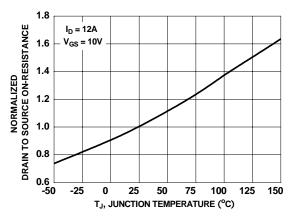


Figure 3. Normalized On-Resistance vs Junction Temperature

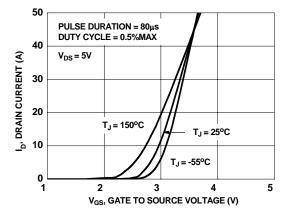


Figure 5. Transfer Characteristics

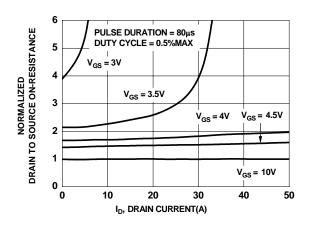


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

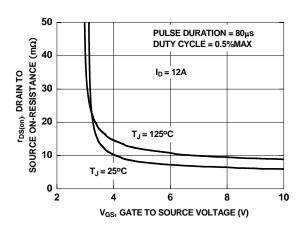


Figure 4. On-Resistance vs Gate to Source Voltage

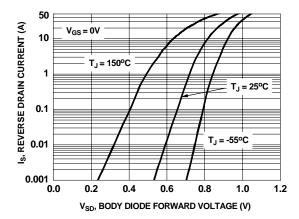


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

## Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

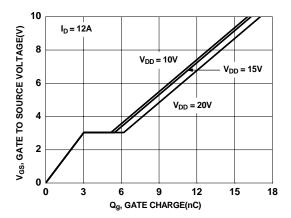


Figure 7. Gate Charge Characteristics

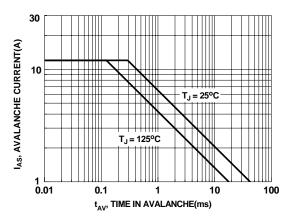


Figure 9. Unclamped Inductive Switching Capability

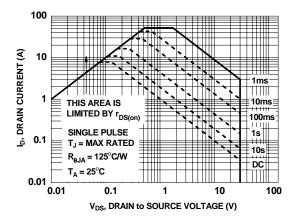


Figure 11. Forward Bias Safe Operating Area

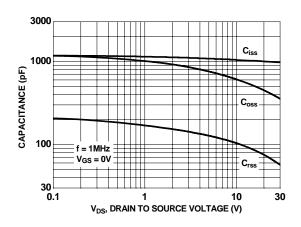


Figure 8. Capacitance vs Drain to Source Voltage

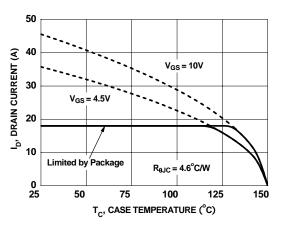


Figure 10. Maximum Continuous Drain Current vs Case Temperature

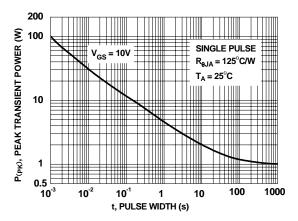


Figure 12. Single Pulse Maximum Power Dissipation

# **Typical Characteristics** T<sub>J</sub> = 25°C unless otherwise noted

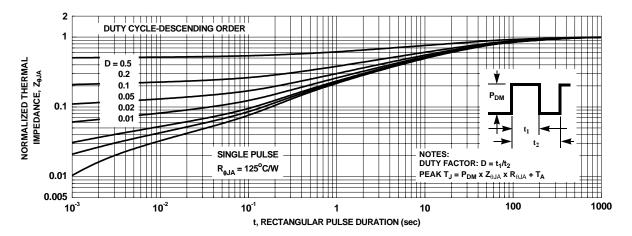


Figure 13. Transient Thermal Response Curve

### **Dimensional Outline and Pad Layout** -3.30±0.10-2.37 MIN SYM PKG Ė -(0.45) 8 5 2.15 MIN (0.40)PKG Q-PKGÇ $3.30\pm0.10$ (0.65) $\bigcirc$ 0.70 MIN 4 1 0.65 -0.42 MIN SEE DETAIL A 1.95 LAND PATTERN RECOMMENDATION 1.95 0.65 $0.32 \pm 0.05 -$ ◆ 0.10 C A B $-0.40\pm0.10$ (0.20)PKGÇ $2.00\pm0.10$ $(0.39)^{\frac{1}{3}}$ 8 (2.27) -NOTES: UNLESS OTHERWISE SPECIFIED (0.52)-PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. BA, DATED OCTOBER 2002. 0.10 C ALL DIMENSIONS ARE IN MILLIMETERS. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR 1.10 BURRS DOES NOT EXCEED 0.10MM. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994. DRAWING FILE NAME: PQFN08BREV1 △ 0.08 C 0.05 С $0.20\pm0.025$ **SEATING** PLANE DETAIL A PQFN08BREV1





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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	This datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

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